

TLV323x 20ns High-Speed Comparator with Rail-to-Rail Input

1 Features

- Propagation delay: 20ns
- Input offset voltage: +/- 4mV maximum
- Low supply current: 200µA per channel
- Input voltage range extends 100mV beyond either rail
- Internal hysteresis: 1.55mV
- Power-on-reset provides a known startup condition (Dual channel only)
- Push-pull output
- Temperature range: -40°C to +125°C

2 Applications

- [Mobile phones & tablets](#)
- [Headsets/headphones & earbuds](#)
- [PC & notebooks](#)
- [Gas detector](#)
- [Smoke & heat detector](#)
- [Motion Detector](#)
- [Gas meter](#)
- [Servo drive position sensor](#)

3 Description

The TLV323x are a family of 5V single and dual channel comparators with push-pull outputs. The family has an excellent speed-to-power combination with a propagation delay of 20ns and a full supply voltage range of 2.7V to 5V with a quiescent supply current of only 200µA per channel.

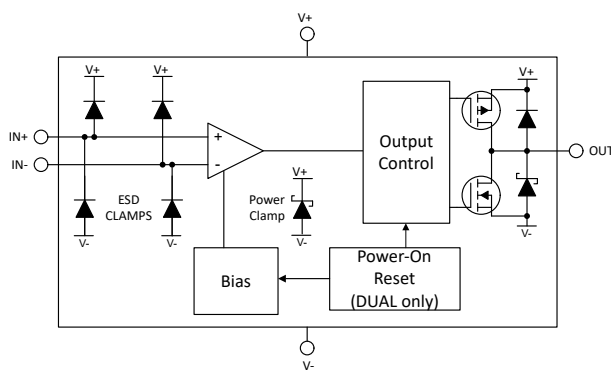
Likewise, the TLV323x are conveniently available in standard leaded and leadless packages with features such as rail-to-rail inputs, low offset voltage, and large output drive current. These features along with fast response time make the comparators well-suited for current sensing, zero-cross detection, and a variety of other applications where precision and speed is critical.

All devices are specified for operation across the expanded temperature range of -40°C to 125°C.

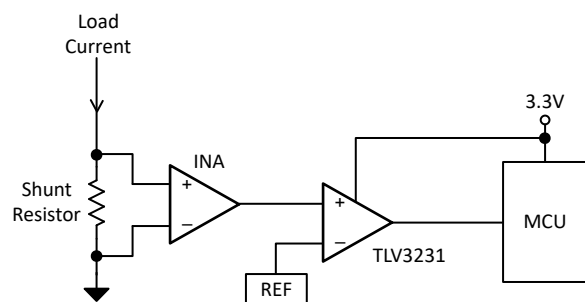
Device Information

| PART NUMBER | PACKAGE (1) | BODY SIZE (NOM) (2) |
|-------------|-------------|---------------------|
| TLV3231 | SC-70 (5) | 1.25mm × 2.00mm |
| | SOT-23 (5) | 1.60mm × 2.90mm |
| TLV3232 | VSSOP (8) | 3.00mm × 3.00mm |
| | WSON (8) | 2.00mm × 2.00mm |

- (1) For all available packages, see the orderable addendum at the end of the data sheet.
- (2) The package size (length × width) is a nominal value and includes pins, where applicable.



Block Diagram



Low-Side Current Sensing

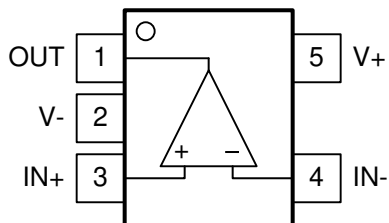


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4 Pin Configuration and Functions

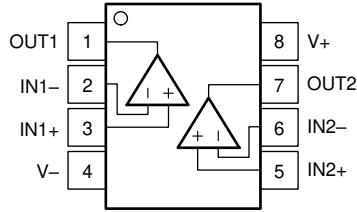
Pin Configurations: TLV3231 and TLV3232



**DCK, DBV Packages
SC70, SOT-23-5
Top View
(Standard "North West" Pinout)**

Table 4-1. Pin Functions: TLV3231

| PIN | | I/O | DESCRIPTION |
|------|-----|-----|-------------------------|
| NAME | NO. | | |
| OUT | 1 | O | Output |
| V- | 2 | - | Negative supply voltage |
| IN+ | 3 | I | Non-inverting (+) input |
| IN- | 4 | I | Inverting (-) input |
| V+ | 5 | - | Positive supply voltage |



**DGK, DSG Packages
8-Pin VSSOP, WSON
Top View**

Table 4-2. Pin Functions: TLV3232

| PIN | | I/O | DESCRIPTION |
|------|-----|-----|------------------------------------|
| NAME | NO. | | |
| IN1+ | 1 | I | Noninverting input, channel 1 |
| IN1- | 2 | I | Inverting input, channel 1 |
| IN2- | 3 | I | Inverting input, channel 2 |
| IN2+ | 4 | I | Noninverting input, channel 2 |
| OUT1 | 7 | O | Output, channel 1 |
| OUT2 | 6 | O | Output, channel 2 |
| V- | 5 | - | Negative (lowest) supply or ground |
| V+ | 8 | - | Positive (highest) supply |

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

| | MIN | MAX | UNIT |
|------------------------------------------------|------|------------|------|
| Supply voltage $V_S = (V+) - (V-)$ | | 6 | V |
| Differential input voltage, V_{ID} | -6 | 6 | V |
| Input pins (IN+, IN-) from (V-) ⁽²⁾ | -0.5 | (V+) + 0.5 | V |
| Current into input pins (IN+, IN-) | -10 | 10 | mA |
| Output short-circuit current | -100 | 100 | mA |
| Output short-circuit duration | | 10 | s |
| Junction temperature, T_J | | 150 | °C |
| Storage temperature, T_{stg} | -65 | 150 | °C |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) Input terminals are diode-clamped to (V-) and (V+). Input signals that can swing more than 0.5V beyond the supply rails must be current-limited to 10mA or less.

5.2 ESD Ratings

| | | | VALUE | UNIT |
|-------------|-------------------------|--------------------------------------------------------------------------------|-------|------|
| $V_{(ESD)}$ | Electrostatic discharge | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾ | ±2000 | V |
| $V_{(ESD)}$ | Electrostatic discharge | Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾ | ±1000 | V |

- (1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| | MIN | MAX | UNIT |
|------------------------------------|------------|------------|------|
| Supply voltage $V_S = (V+) - (V-)$ | 2.7 | 5.5 | V |
| Input voltage range | (V-) - 0.1 | (V+) + 0.1 | V |
| Ambient temperature, T_A | -40 | 125 | °C |

5.4 Thermal Information, TLV3231

| THERMAL METRIC ⁽¹⁾ | | TLV3231 | | UNIT |
|-------------------------------|----------------------------------------------|--------------|------------|------|
| | | DBV (SOT-23) | DCK (SC70) | |
| | | 5 PINS | 5 PINS | |
| R _{θJA} | Junction-to-ambient thermal resistance | 196.4 | 220 | °C/W |
| R _{θJC(top)} | Junction-to-case (top) thermal resistance | 94 | 135 | °C/W |
| R _{θJB} | Junction-to-board thermal resistance | 63 | 65 | °C/W |
| Ψ _{JT} | Junction-to-top characterization parameter | 30.5 | 34 | °C/W |
| Ψ _{JB} | Junction-to-board characterization parameter | 62.6 | 65 | °C/W |
| R _{θJC(bot)} | Junction-to-case (bottom) thermal resistance | n/a | n/a | °C/W |

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

5.5 Thermal Information, TLV3232

| THERMAL METRIC ⁽¹⁾ | | TLV3232 | | UNIT |
|-------------------------------|----------------------------------------------|-------------|------------|------|
| | | DGK (VSSOP) | DSG (WSON) | |
| | | 8 PINS | 8 PINS | |
| R _{θJA} | Junction-to-ambient thermal resistance | 154.5 | 78.1 | °C/W |
| R _{θJC(top)} | Junction-to-case (top) thermal resistance | 88.8 | 99.9 | °C/W |
| R _{θJB} | Junction-to-board thermal resistance | 49.1 | 44.4 | °C/W |
| Ψ _{JT} | Junction-to-top characterization parameter | 1.8 | 5 | °C/W |
| Ψ _{JB} | Junction-to-board characterization parameter | 87.4 | 44.4 | °C/W |
| R _{θJC(bot)} | Junction-to-case (bottom) thermal resistance | n/a | 19.5 | °C/W |

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

5.6 Electrical Characteristics

$V_S = 2.7V$ to $5V$, $V_{CM} = V_S / 2$; at $T_A = 25^\circ C$ (unless otherwise noted). Typical values are at $T_A = 25^\circ C$.

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|----------------------------------|------------------------------------|---------------------------------------------------------------------------|------------|-----------|------------|---------|
| DC Input Characteristics | | | | | | |
| V_{IO} | Input Offset Voltage | $V_S = 5V$, $V_{CM} = V_S / 2$ | | ± 0.5 | ± 4 | mV |
| V_{IO} | Input Offset Voltage | $V_S = 5V$, $V_{CM} = V_S / 2$, $T_A = -40$ to $125^\circ C$ | | | ± 4.5 | mV |
| V_{HYS} | Hysteresis | $V_S = 5V$, $V_{CM} = V_S / 2$ | 0.5 | 1.55 | 3 | mV |
| V_{HYS} | Hysteresis | $V_S = 5V$, $V_{CM} = V_S / 2$, $T_A = -40$ to $125^\circ C$ | | | 3.5 | mV |
| V_{CM} | Common-mode voltage range | | (V-) - 0.1 | | (V+) + 0.1 | V |
| I_B | Input bias current | $V_S = 5V$, $V_{CM} = V_S / 2$, $T_A = -40$ to $125^\circ C$ | | 0.01 | 10 | nA |
| I_{OS} | Input offset current | $V_S = 5V$, $V_{CM} = V_S / 2$ | | | 200 | pA |
| C_{IN} | Input capacitance | | | 2 | | pF |
| CMRR | Common-mode rejection ratio | $V_{CM} = V_{EE} - 0.1V$ to $V_{CC} + 0.1V$ | | 82 | | dB |
| DC Output Characteristics | | | | | | |
| V_{OH} | Voltage swing from (V+) | $V_S = 5V$, (V-) = 0V, $I_{Source} = 2mA$ | | | 200 | mV |
| V_{OL} | Voltage swing from (V-) | $V_S = 5V$, (V-) = 0V, $I_{Sink} = 2mA$ | | | 200 | mV |
| I_{SC} | Short-circuit current | $V_S = 5V$, sourcing | | 45 | | mA |
| | | $V_S = 5V$, sinking | | 45 | | |
| Power Supply | | | | | | |
| I_Q | Supply current / Channel | $V_S = 2.7V$ and $5V$, no load, Output Low | | 200 | 250 | μA |
| I_Q | Supply current / Channel | $V_S = 2.7V$ and $5V$, no load, Output Low, $T_A = -40$ to $125^\circ C$ | | | 350 | μA |
| $V_{POR (positive)}$ | Power-On Reset Voltage (dual only) | | | 2.1 | | V |
| PSRR | Power Supply Rejection Ratio | $V_S = 2.7V$ to $5.5V$, no load, $T_A = -40$ to $125^\circ C$ | | 92 | | dB |

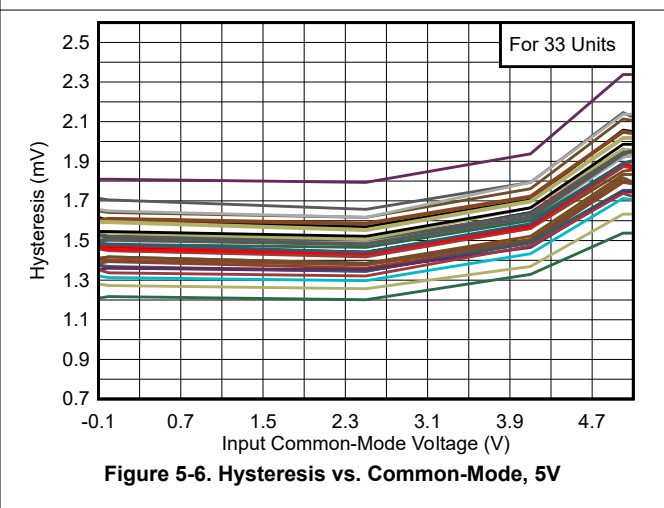
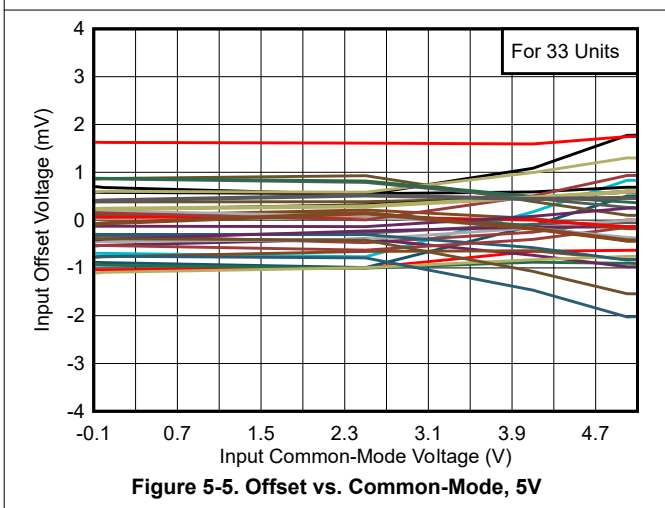
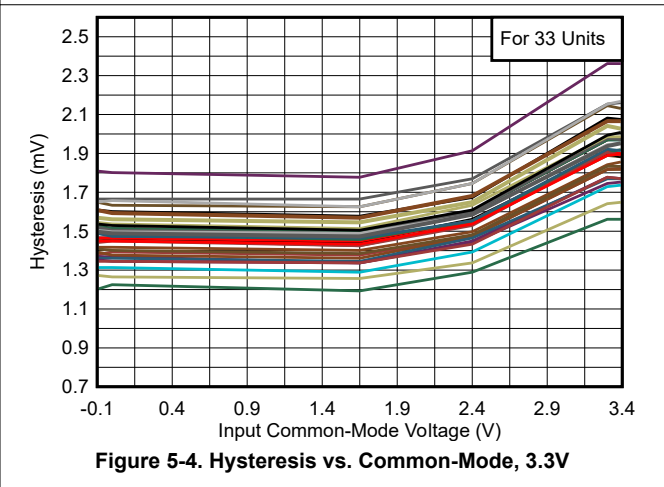
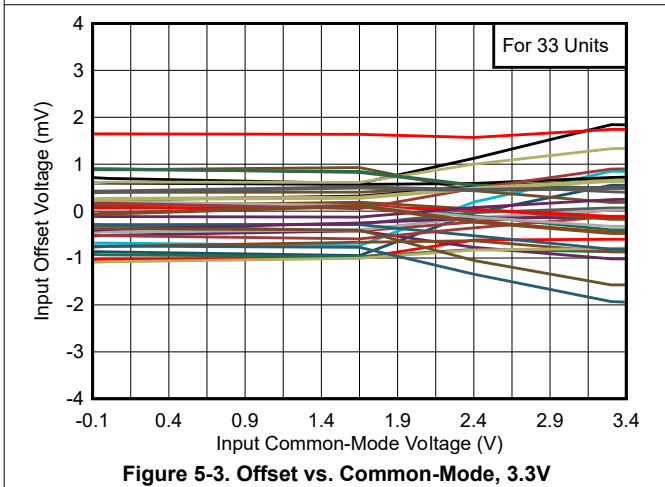
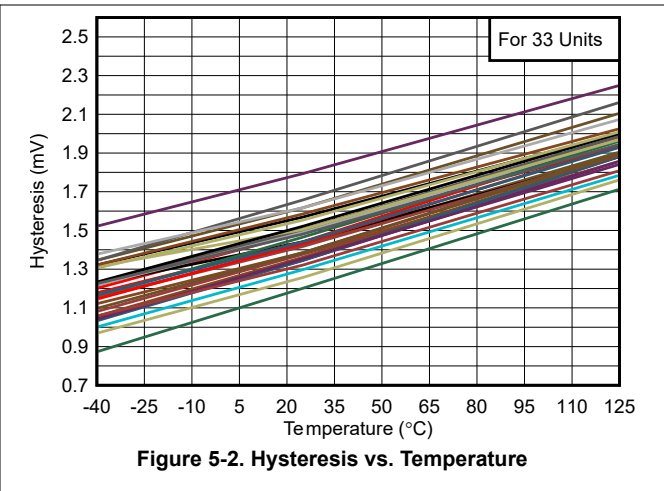
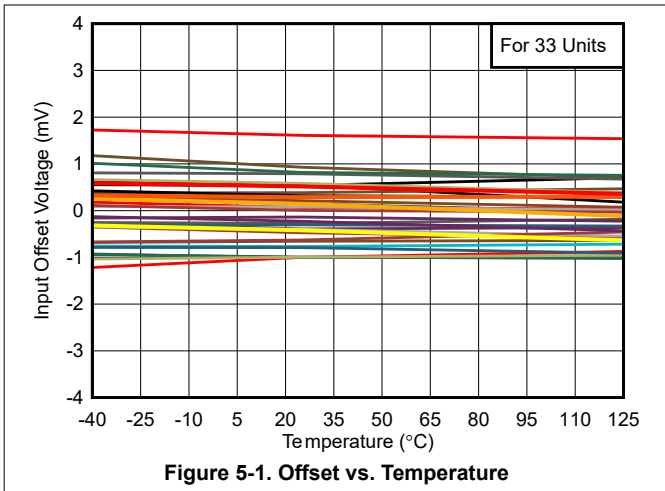
5.7 Switching Characteristics

For $V_S = 5V$, $V_{CM} = V_S / 2$; $C_L = 15pF$ at $T_A = 25^\circ C$ (Unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--------------|-------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------|-----|-----|-----|---------|
| t_{PHL} | Propagation delay time, high to-low (single) | Midpoint of input to midpoint of output, $V_{OD} = 10mV$ | | 22 | | ns |
| t_{PHL} | Propagation delay time, high to-low (dual) | Midpoint of input to midpoint of output, $V_{OD} = 10mV$ | | 25 | | ns |
| t_{PHL} | Propagation delay time, high to-low (single and dual) | Midpoint of input to midpoint of output, $V_{OD} = 50mV$ | | 15 | 25 | ns |
| t_{PLH} | Propagation delay time, low-to high (single) | Midpoint of input to midpoint of output, $V_{OD} = 10mV$ | | 20 | | ns |
| t_{PLH} | Propagation delay time, low-to high (dual) | Midpoint of input to midpoint of output, $V_{OD} = 10mV$ | | 25 | | ns |
| t_{PLH} | Propagation delay time, low-to high (single and dual) | Midpoint of input to midpoint of output, $V_{OD} = 50mV$ | | 15 | 25 | ns |
| f_{TOGGLE} | Input toggle frequency | $V_{IN} = 200mV_{PP}$ Sine Wave, When output high reaches 90% of $V_{CC} - V_{EE}$ or output low reaches 10% of $V_{CC} - V_{EE}$ | | 55 | | MHz |
| t_R | Rise time | Measured from 20% to 80% | | 1.6 | | ns |
| t_F | Fall time | Measured from 20% to 80% | | 1.6 | | ns |
| t_{ON} | Power-up time | During power on, (V+) must exceed 2.1V for 4 μ s before the output reflects the input. | | 4.5 | | μ s |

5.8 Typical Characteristics

$T_A = 25^\circ\text{C}$, $V_S = 5\text{V}$, $C_L = 15\text{pF}$, $V_{CM} = V_S/2\text{V}$, $V_{UNDERDRIVE} = 50\text{mV}$, $V_{OVERDRIVE} = 50\text{mV}$ unless otherwise noted.



5.8 Typical Characteristics (continued)

$T_A = 25^\circ\text{C}$, $V_S = 5\text{V}$, $C_L = 15\text{pF}$, $V_{CM} = V_S/2\text{V}$, $V_{UNDERDRIVE} = 50\text{mV}$, $V_{OVERDRIVE} = 50\text{mV}$ unless otherwise noted.

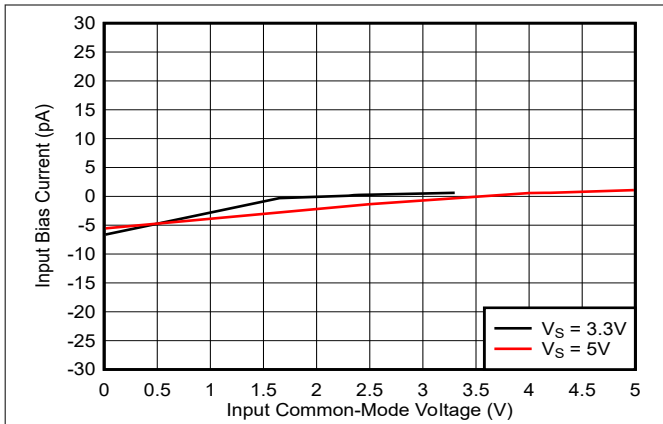


Figure 5-7. Bias Current vs. Common-Mode

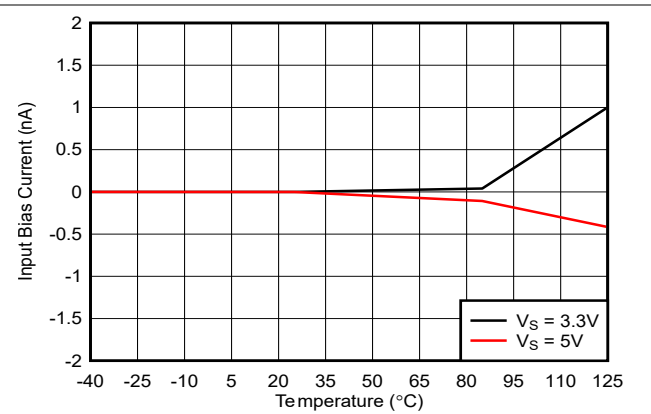


Figure 5-8. Bias Current vs. Temperature

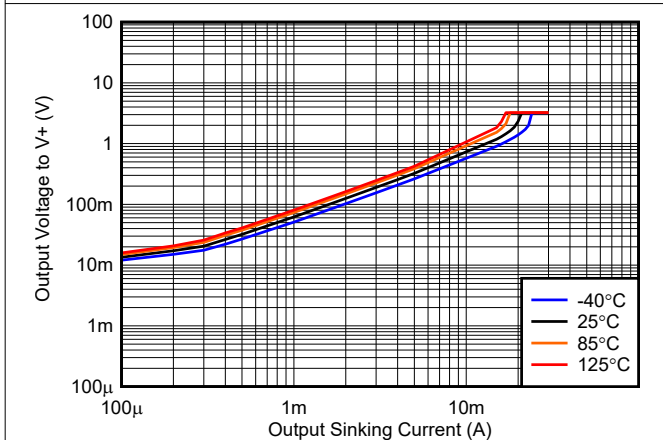


Figure 5-9. Output Voltage vs. Output Sourcing Current, 3.3V

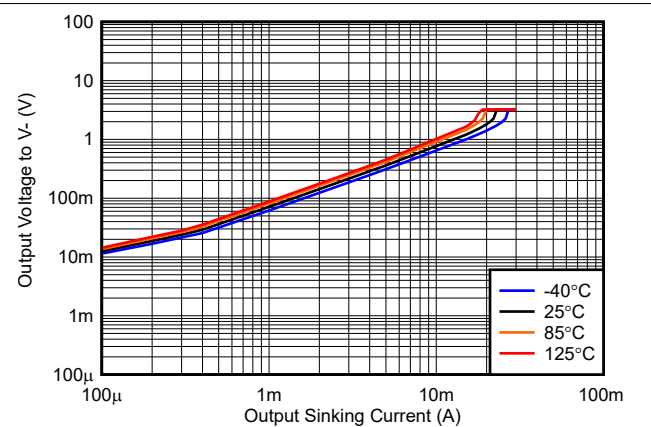


Figure 5-10. Output Voltage vs. Output Sinking Current, 3.3V

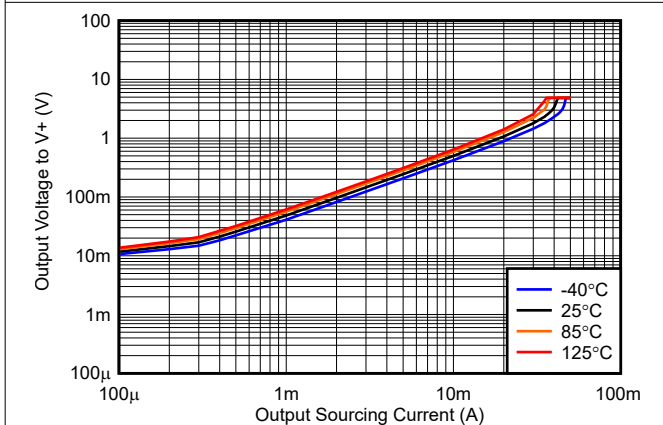


Figure 5-11. Output Voltage vs. Output Sourcing Current, 5V

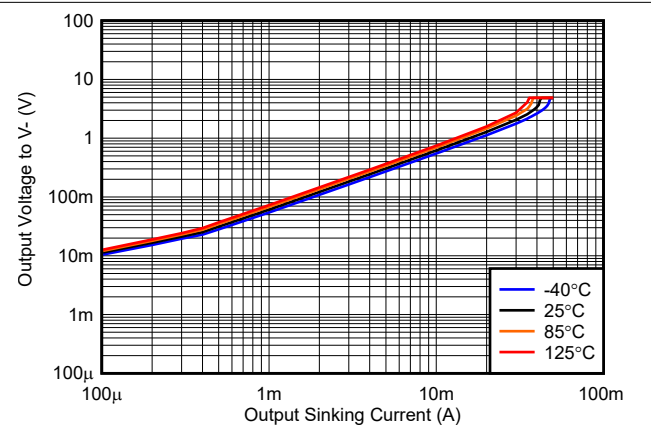


Figure 5-12. Output Voltage vs. Output Sinking Current, 5V

5.8 Typical Characteristics (continued)

$T_A = 25^\circ\text{C}$, $V_S = 5\text{V}$, $C_L = 15\text{pF}$, $V_{CM} = V_S/2\text{V}$, $V_{UNDERDRIVE} = 50\text{mV}$, $V_{OVERDRIVE} = 50\text{mV}$ unless otherwise noted.

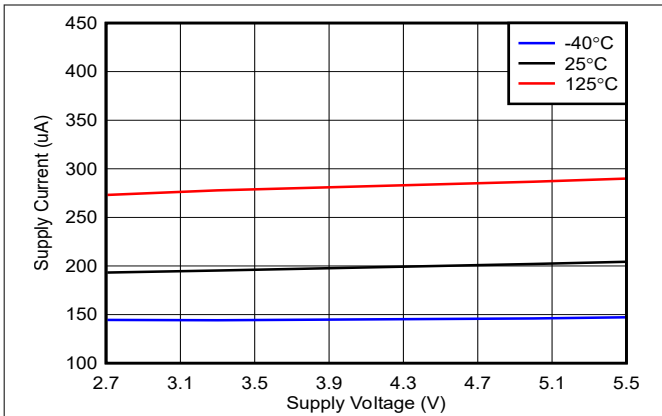


Figure 5-13. Supply Current vs. Supply Voltage (Output Low)

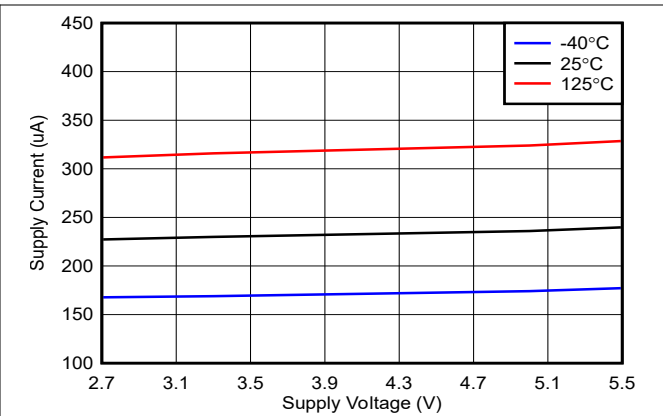


Figure 5-14. Supply Current vs. Supply Voltage (Output High)

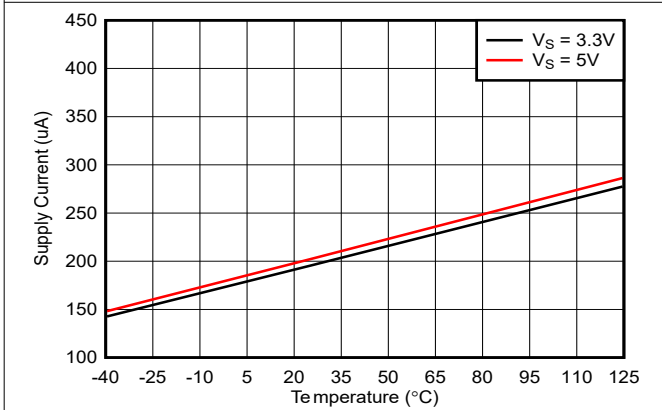


Figure 5-15. Supply Current vs. Temperature (Output Low)

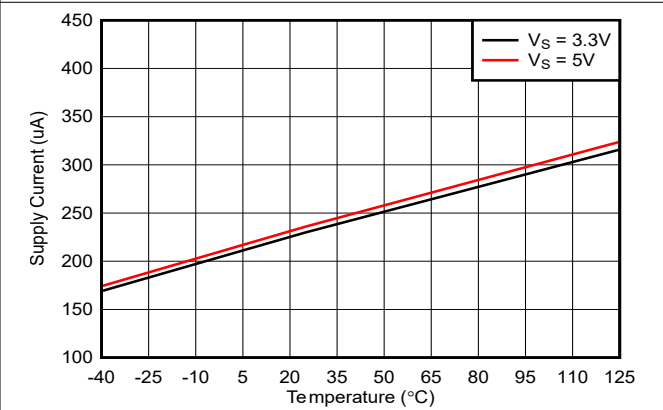


Figure 5-16. Supply Current vs. Temperature (Output High)

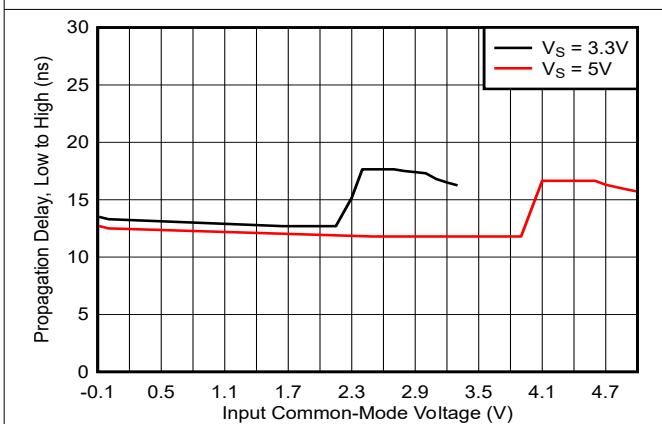


Figure 5-17. Propagation Delay (Low to High) vs. Common-Mode

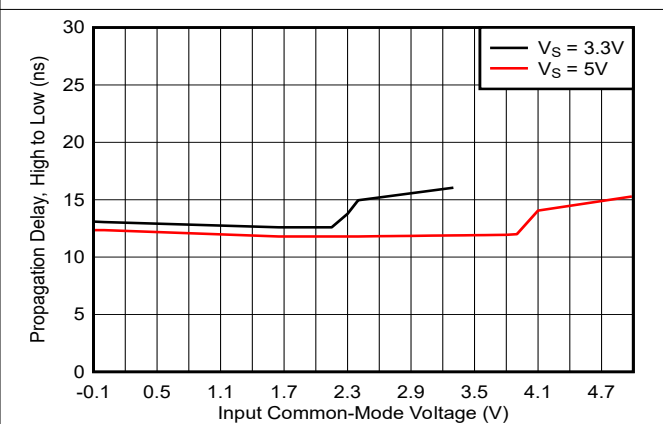


Figure 5-18. Propagation Delay (High to Low) vs. Common-Mode

5.8 Typical Characteristics (continued)

$T_A = 25^\circ\text{C}$, $V_S = 5\text{V}$, $C_L = 15\text{pF}$, $V_{CM} = V_S/2\text{V}$, $V_{UNDERDRIVE} = 50\text{mV}$, $V_{OVERDRIVE} = 50\text{mV}$ unless otherwise noted.

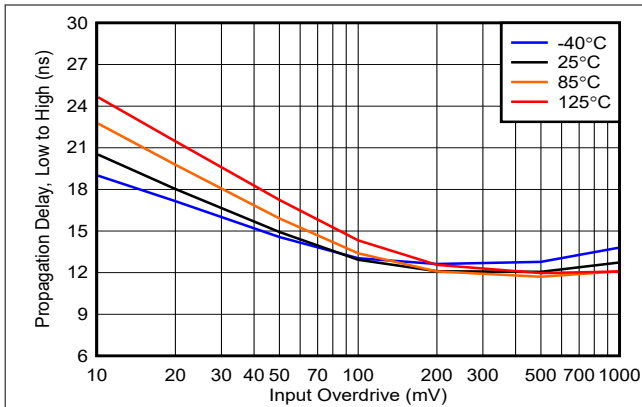


Figure 5-19. SINGLE Propagation Delay (Low to High) vs. Overdrive (3.3V)

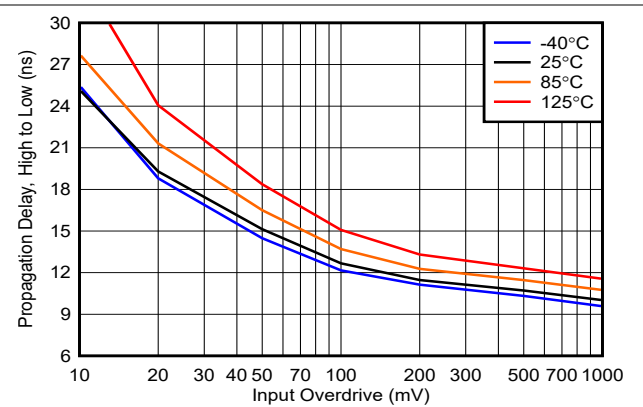


Figure 5-20. SINGLE Propagation Delay (High to Low) vs. Overdrive (3.3V)

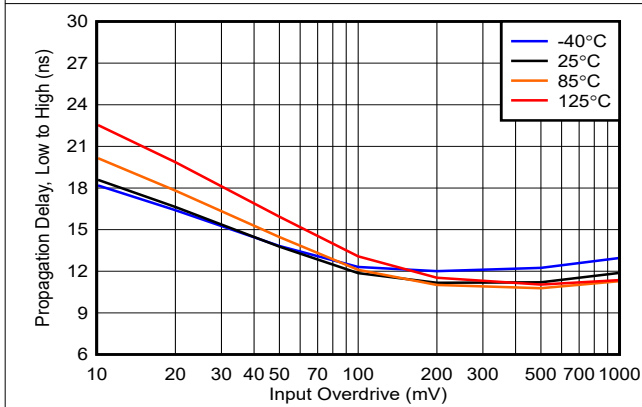


Figure 5-21. SINGLE Propagation Delay (Low to High) vs. Overdrive (5V)

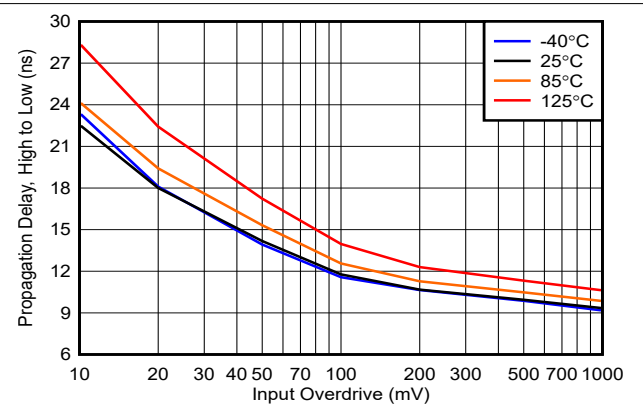


Figure 5-22. SINGLE Propagation Delay (High to Low) vs. Overdrive (5V)

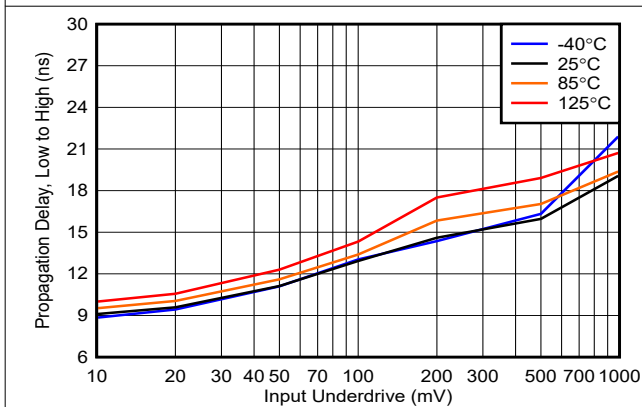


Figure 5-23. SINGLE Propagation Delay (Low to High) vs. Underdrive (3.3V)

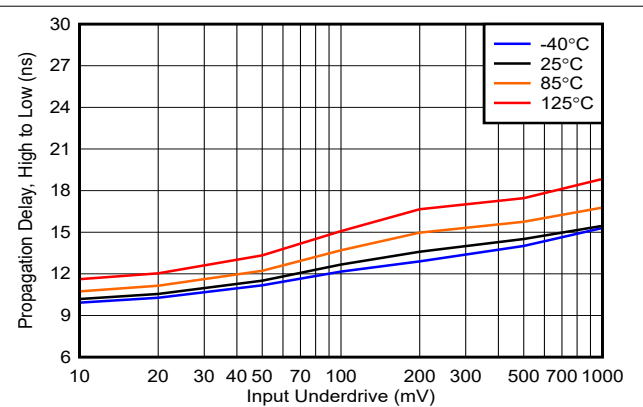


Figure 5-24. SINGLE Propagation Delay (High to Low) vs. Underdrive (3.3V)

5.8 Typical Characteristics (continued)

$T_A = 25^\circ\text{C}$, $V_S = 5\text{V}$, $C_L = 15\text{pF}$, $V_{CM} = V_S/2\text{V}$, $V_{UNDERDRIVE} = 50\text{mV}$, $V_{OVERDRIVE} = 50\text{mV}$ unless otherwise noted.

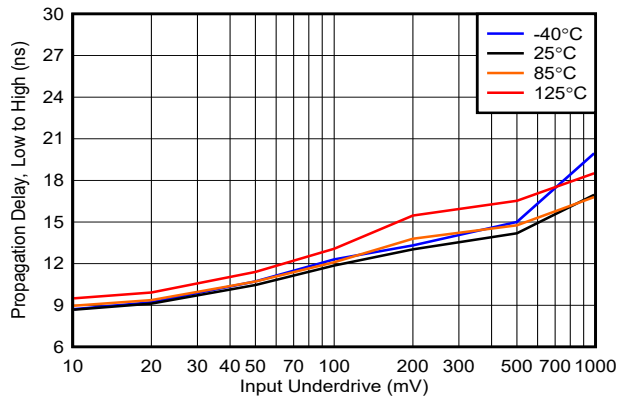


Figure 5-25. SINGLE Propagation Delay (Low to High) vs. Underdrive (5V)

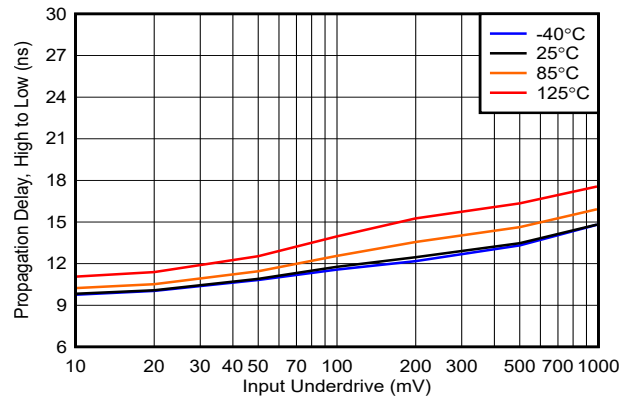


Figure 5-26. SINGLE Propagation Delay (High to Low) vs. Underdrive (5V)

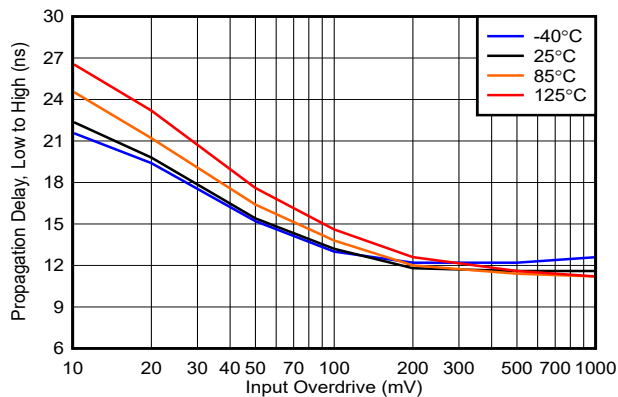


Figure 5-27. DUAL Propagation Delay (Low to High) vs. Overdrive (3.3V)

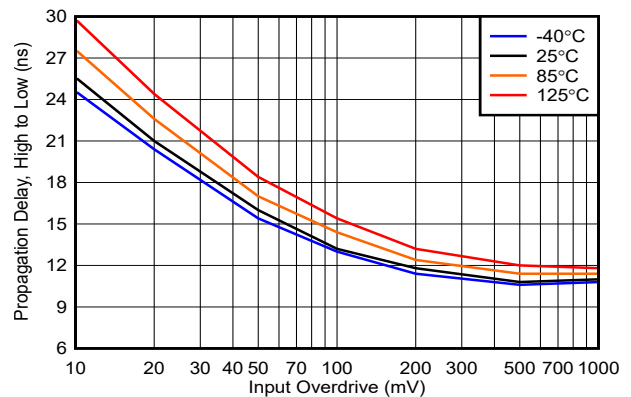


Figure 5-28. DUAL Propagation Delay (High to Low) vs. Overdrive (3.3V)

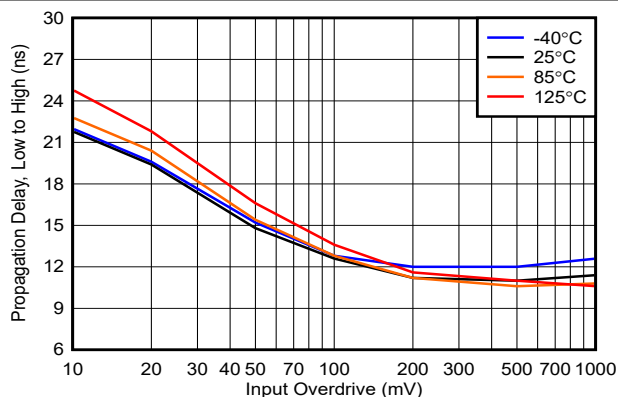


Figure 5-29. DUAL Propagation Delay (Low to High) vs. Overdrive (5V)

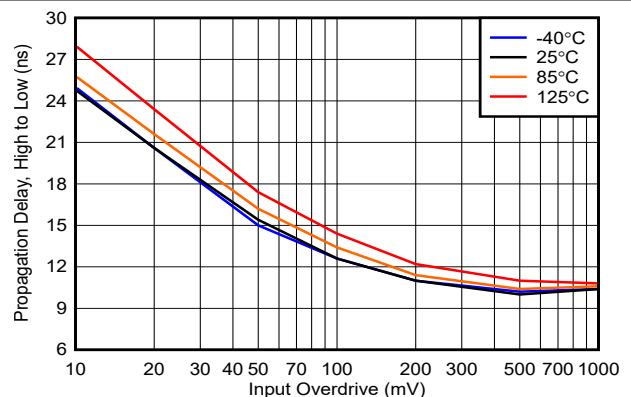


Figure 5-30. DUAL Propagation Delay (High to Low) vs. Overdrive (5V)

5.8 Typical Characteristics (continued)

$T_A = 25^\circ\text{C}$, $V_S = 5\text{V}$, $C_L = 15\text{pF}$, $V_{CM} = V_S/2\text{V}$, $V_{UNDERDRIVE} = 50\text{mV}$, $V_{OVERDRIVE} = 50\text{mV}$ unless otherwise noted.

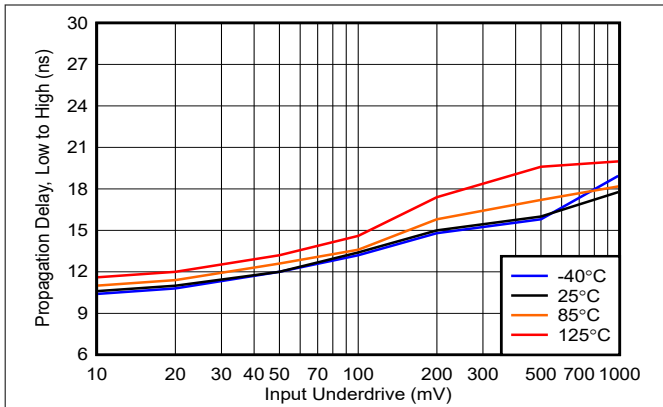


Figure 5-31. DUAL Propagation Delay (Low to High) vs. Underdrive (3.3V)

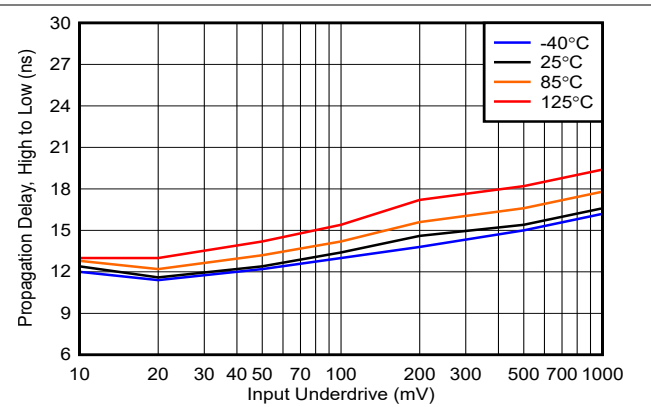


Figure 5-32. DUAL Propagation Delay (High to Low) vs. Underdrive (3.3V)

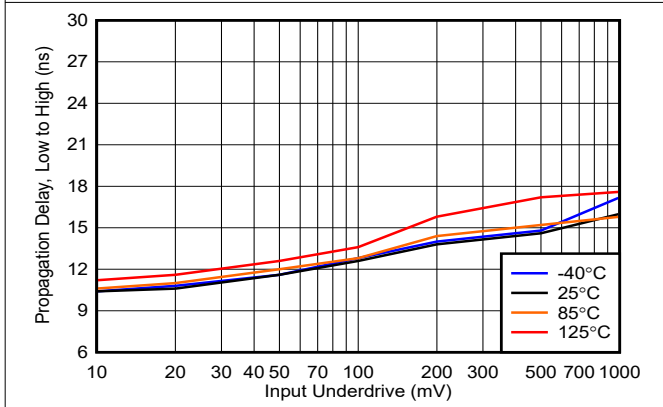


Figure 5-33. DUAL Propagation Delay (Low to High) vs. Underdrive (5V)

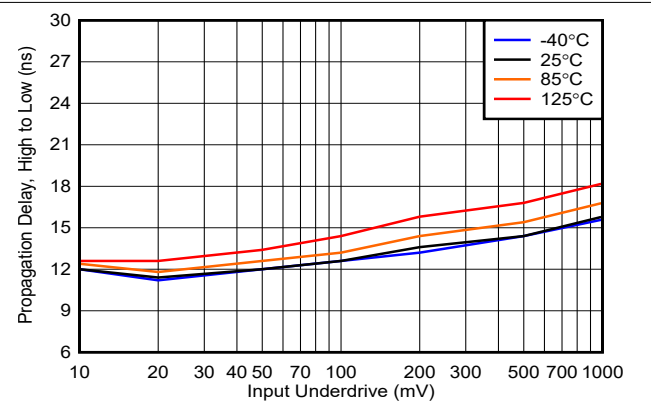


Figure 5-34. DUAL Propagation Delay (High to Low) vs. Underdrive (5V)

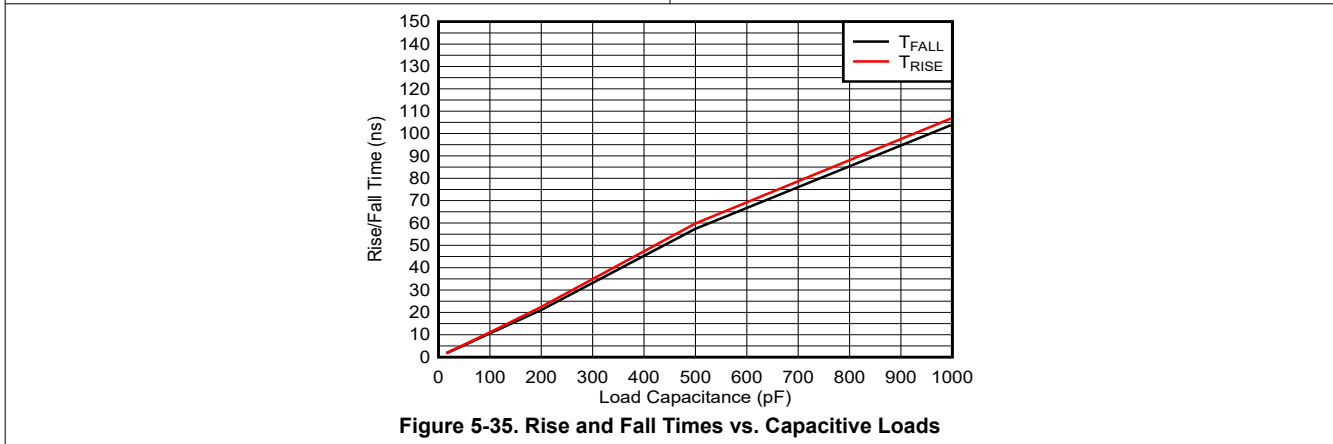


Figure 5-35. Rise and Fall Times vs. Capacitive Loads

6 Detailed Description

6.1 Overview

The TLV323x devices are high-speed comparators with push-pull outputs.

6.2 Functional Block Diagrams

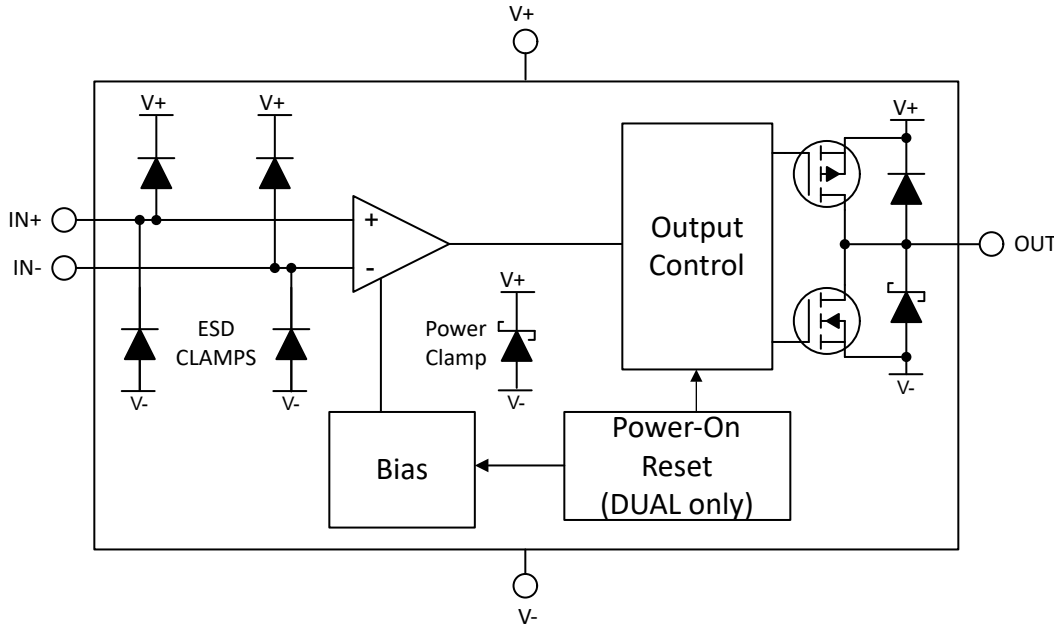


Figure 6-1. Block Diagram

6.3 Feature Description

The TLV323x consumes 200 μ A per channel with 20ns of propagation delay. The TLV323x detects fast voltage and current transients while maintaining low power consumption with single-ended, push-pull outputs.

6.4 Device Functional Modes

6.4.1 Inputs

The inputs incorporate internal ESD protection circuits to (V+) and (V-). Voltages on the inputs are limited to 0.3V beyond the rails.

When connecting to a low impedance source such as a power supply or buffered reference line, TI recommends adding a current-limiting resistor in series with the input to limit any transient currents if the clamps conduct. Limit the current to 10mA or less. One form of series resistance is any resistive input dividers or networks.

6.4.2 Internal Hysteresis

The device hysteresis transfer curve is shown below. This curve is a function of three components: V_{TH} , V_{OS} , and V_{HYST} :

- V_{TH} is the actual set voltage or threshold trip voltage.
- V_{OS} is the internal offset voltage between V_{IN+} and V_{IN-} . This voltage is added to V_{TH} to form the actual trip point at which the comparator must respond to change output states.
- V_{HYST} is the internal hysteresis (or trip window) that is designed to reduce comparator sensitivity to noise.
(typically 1.55mV for the TLV323x family)

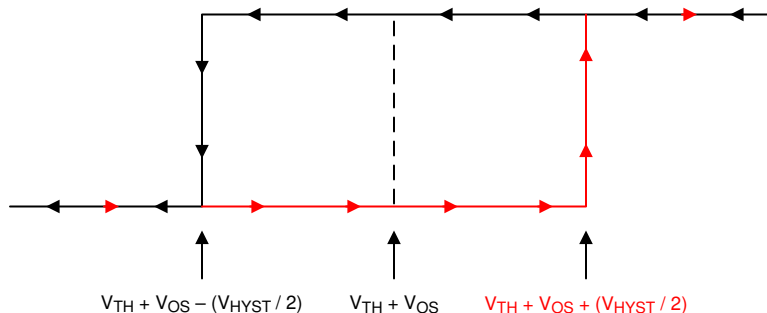


Figure 6-2. Hysteresis Transfer Curve

6.4.3 Outputs

The TLV323x features a push-pull output stage capable of both sinking and sourcing current. This allows driving loads such as LED's and MOSFET gates, as well as eliminating the need for a power-wasting external pull-up resistor. The push-pull output must never be connected to another output.

Directly shorting the output to the supply rails ((V+) when output "low" or (V-) when output "High") can result in thermal runaway and eventual device destruction. If output shorts are possible, a series current limiting resistor is recommended to limit the power dissipation.

Unused push-pull outputs must be left floating, and never tied to a supply, ground, or another output.

6.4.4 ESD Protection

The inputs and outputs incorporate internal ESD protection circuits to (V+) and (V-).

Voltages on the inputs are limited to 0.3V beyond the rails. If the inputs are to be connected to a low impedance source, such as a power supply or buffered reference line, TI recommends adding a current-limiting resistor in series with the input to limit any transient currents in case the clamps conduct. Limit the current to 10mA or less.

6.4.5 Power-On Reset (POR) - Dual Channel Only

The TLV3232 devices have an internal Power-on-Reset (POR) circuit for known start-up or power-down conditions. While the power supply (V+) is ramping up or ramping down, the POR circuitry is activated for up to 2.5us after the V_{POR} of 2.2V is crossed. When the supply voltage is equal to or greater than the minimum supply voltage, and after the delay period, the comparator output reflects the state of the differential input (V_{ID}).

For the TLV3232 devices, the output is held low during the POR period (t_{on}) as shown below.

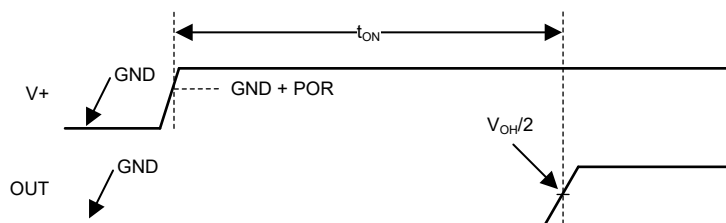


Figure 6-3. Power-On Reset Timing Diagram

7 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

7.1 Application Information

7.1.1 Basic Comparator Definitions

7.1.1.1 Operation

The basic comparator compares the input voltage (V_{IN}) on one input to a reference voltage (V_{REF}) on the other input. In the [Figure 7-1](#) example below, if V_{IN} is less than V_{REF} , the output voltage (V_O) is logic low (V_{OL}). If V_{IN} is greater than V_{REF} , the output voltage (V_O) is at logic high (V_{OH}). [Table 7-1](#) summarizes the output conditions. The output logic can be inverted by simply swapping the input pins.

Table 7-1. Output Conditions

| Inputs Condition | Output |
|------------------|------------------------------------------------------------|
| $IN+ > IN-$ | HIGH (V_{OH}) |
| $IN+ = IN-$ | Indeterminate (chatters - see Hysteresis) |
| $IN+ < IN-$ | LOW (V_{OL}) |

7.1.1.2 Propagation Delay

There is a delay between from when the input crosses the reference voltage and the output responds. This is called the Propagation Delay. Propagation delay can be different between high-to low and low-to-high input transitions. This is shown as t_{pLH} and t_{pHL} in [Figure 7-1](#) and is measured from the mid-point of the input to the midpoint of the output.

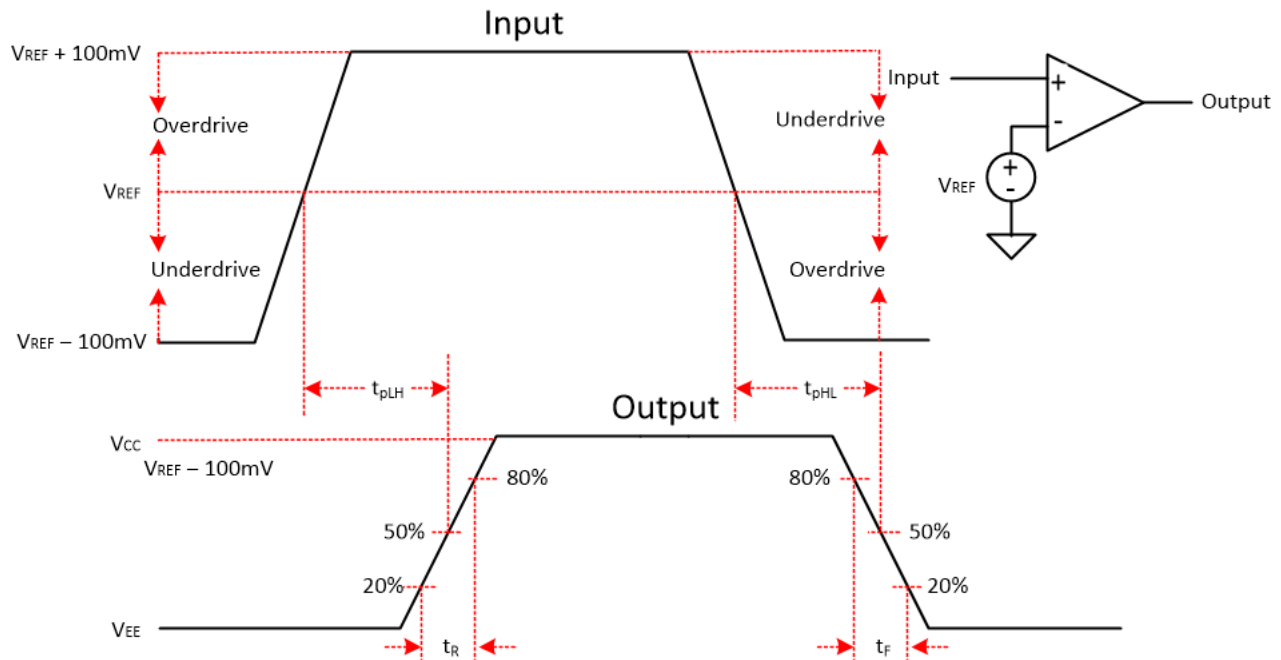


Figure 7-1. Comparator Timing Diagram

7.1.1.3 Overdrive Voltage

The overdrive voltage, V_{OD} , is the amount of input voltage beyond the reference voltage (and not the total input peak-to-peak voltage). The overdrive voltage can influence the propagation delay (t_p). The smaller the overdrive voltage, the longer the propagation delay, particularly when $<100\text{mV}$. If the fastest speeds are desired, TI recommends applying the highest amount of overdrive possible.

The risetime (t_r) and falltime (t_f) is the time from the 20% and 80% points of the output waveform.

7.1.2 Hysteresis

The basic comparator configuration can produce a noisy "chatter" output if the applied differential input voltage is near the comparator's offset voltage. This typically occurs when the input signal is moving very slowly across the switching threshold of the comparator. This problem can be prevented by adding external hysteresis to the comparator.

Since the TLV323x devices only have a minimal amount of internal hysteresis of 1.55mV, external hysteresis can be applied in the form of a positive feedback loop that adjusts the trip point of the comparator depending on the current output state.

The hysteresis transfer curve is shown in Figure 7-2. This curve is a function of three components: V_{TH} , V_{OS} , and V_{HYST} :

- V_{TH} is the actual set voltage or threshold trip voltage.
- V_{OS} is the internal offset voltage between V_{IN+} and V_{IN-} . This voltage is added to V_{TH} to form the actual trip point at which the comparator must respond to change output states.
- V_{HYST} is the hysteresis (or trip window) that is designed to reduce comparator sensitivity to noise.

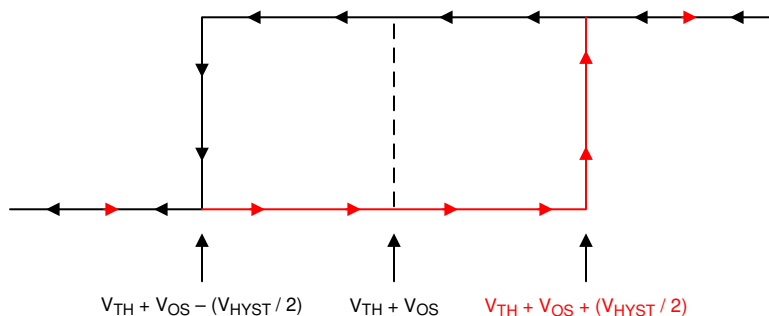


Figure 7-2. Hysteresis Transfer Curve

For more information, please see Application Note SBOA219 "Comparator with and without hysteresis circuit".

7.1.2.1 Inverting Comparator With Hysteresis

The inverting comparator with hysteresis requires a three-resistor network that is referenced to the comparator supply voltage (V_{CC}), as shown in Figure 7-3.

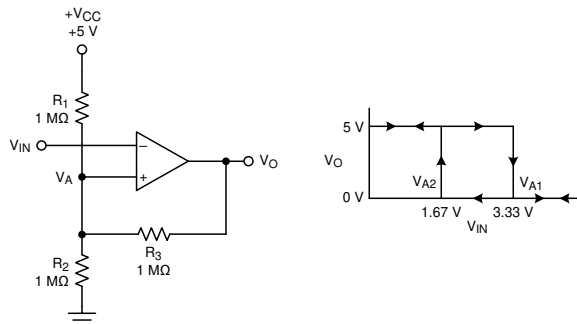


Figure 7-3. TLV3231 in an Inverting Configuration With Hysteresis

The equivalent resistor networks when the output is high and low are shown in [Figure 7-3](#).



Figure 7-4. Inverting Configuration Resistor Equivalent Networks

When V_{IN} is less than V_A , the output voltage is high (for simplicity, assume V_O switches as high as V_{CC}). The three network resistors can be represented as $R1 \parallel R3$ in series with $R2$, as shown in [Figure 7-4](#).

[Equation 1](#) below defines the high-to-low trip voltage (V_{A1}).

$$V_{A1} = V_{CC} \times \frac{R2}{(R1 \parallel R3) + R2} \quad (1)$$

When V_{IN} is greater than V_A , the output voltage is low. In this case, the three network resistors can be presented as $R2 \parallel R3$ in series with $R1$, as shown in [Equation 2](#).

Use [Equation 2](#) to define the low to high trip voltage (V_{A2}).

$$V_{A2} = V_{CC} \times \frac{R2 \parallel R3}{R1 + (R2 \parallel R3)} \quad (2)$$

[Equation 3](#) defines the total hysteresis provided by the network.

$$\Delta V_A = V_{A1} - V_{A2} \quad (3)$$

7.1.2.2 Non-Inverting Comparator With Hysteresis

A non-inverting comparator with hysteresis requires a two-resistor network and a voltage reference (V_{REF}) at the inverting input, as shown in [Figure 7-5](#),

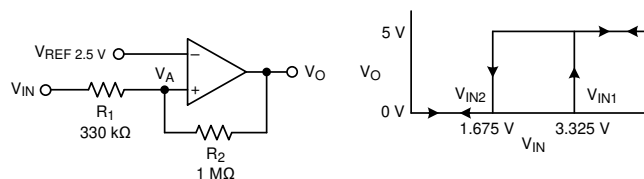


Figure 7-5. TLV3231 in a Non-Inverting Configuration With Hysteresis

The equivalent resistor networks when the output is high and low are shown in [Figure 7-6](#).

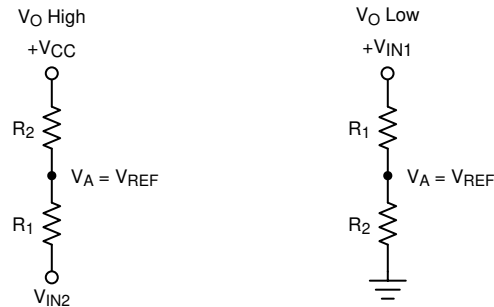


Figure 7-6. Non-Inverting Configuration Resistor Networks

When V_{IN} is less than V_{REF} , the output is low. For the output to switch from low to high, V_{IN} must rise above the V_{IN1} threshold. Use [Equation 4](#) to calculate V_{IN1} .

$$V_{IN1} = R1 \times \frac{V_{REF}}{R2} + V_{REF} \quad (4)$$

When V_{IN} is greater than V_{REF} , the output is high. For the comparator to switch back to a low state, V_{IN} must drop below V_{IN2} . Use [Equation 5](#) to calculate V_{IN2} .

$$V_{IN2} = \frac{V_{REF} (R1 + R2) - V_{CC} \times R1}{R2} \quad (5)$$

The hysteresis of this circuit is the difference between V_{IN1} and V_{IN2} , as shown in [Equation 6](#).

$$\Delta V_{IN} = V_{CC} \times \frac{R1}{R2} \quad (6)$$

For more information, please see Application Notes SNOA997 "[Inverting comparator with hysteresis circuit](#)" and SBOA313 "[Non-Inverting Comparator With Hysteresis Circuit](#)".

7.2 Typical Applications

7.2.1 Low-Side Current Sensing

The figure below shows a simple low-side current sensing circuit using a high-speed comparator. Since this design does not utilize an amplifier, the response time is only limited by the propagation delay of the comparator. With faster response time, the design is well-suited for short-circuit detection when speed is more important than accuracy. When the voltage across the shunt resistor reaches the critical over-current threshold created by R1 and R2, the comparator output changes state.

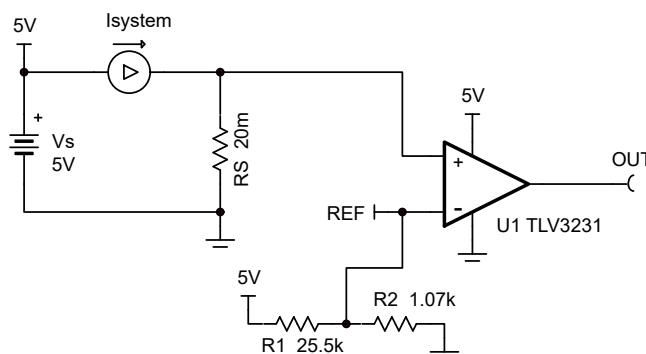


Figure 7-7. Current Sensing

7.2.1.1 Design Requirements

For this design, follow these design requirements:

- Alert (overcurrent) event occurs when system current (I_{system}) reaches 10A
- Alert signal (OUT) is active high
- Operate from a 5V power supply

7.2.1.2 Detailed Design Procedure

To minimize power dissipation and voltage drop across the shunt resistor (R_S), a value of $20m\Omega$ is selected. Since the overcurrent level of 10A creates a $200mV$ drop across R_S , R_1 and R_2 are calculated to create the voltage divider value of $200mV$ from the regulated 5V supply voltage. If the system is expected to operate close to the 10A maximum, hysteresis can be added to the design as shown in [Non-Inverting Comparator With Hysteresis](#).

7.2.1.3 Application Curve

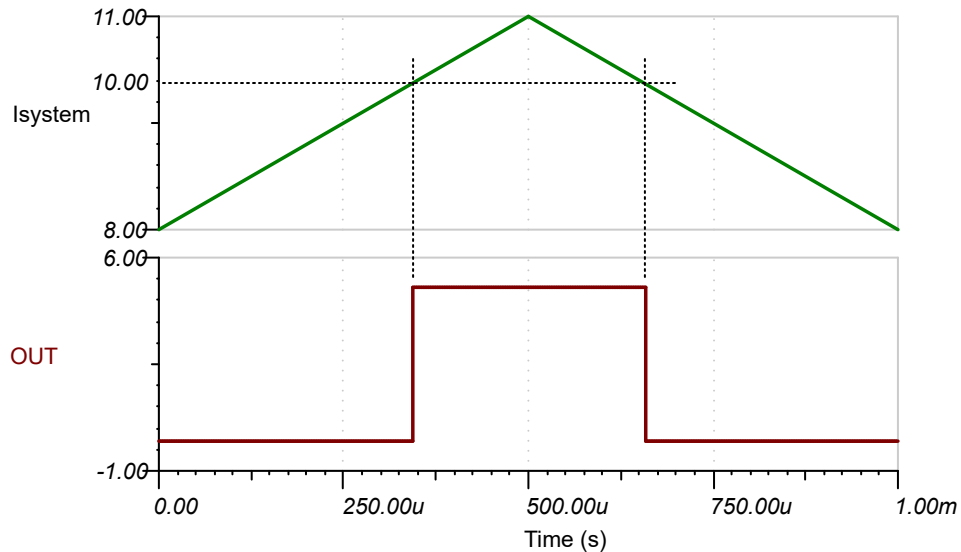


Figure 7-8. Overcurrent Results

7.3 Power Supply Recommendations

Due to the fast output edges, bypass capacitors are required on the supply pin to prevent supply ringing and false triggers and oscillations. Bypass the supply directly at *each* device with a low ESR $0.1\mu F$ ceramic bypass capacitor directly between the ($V+$) pin and ground pins. Narrow peak currents can be drawn during the output transition time, particularly for the push-pull output device. These narrow pulses can cause un-bypassed supply lines and poor grounds to ring, possibly causing variation that can eat into the input voltage range and create an inaccurate comparison or even oscillations.

The device can be powered from both "split" supplies ($(V+)$ & $(V-)$), or "single" supplies ($(V+)$ and GND), with GND applied to the ($V-$) pin. Input signals must stay within the recommended input range for either type. Note that with a "split" supply the output now swings "low" (V_{OL}) to ($V-$) potential and not GND.

7.4 Layout

7.4.1 Layout Guidelines

Accurate comparator applications require a stable power supply with minimized noise and glitches. Output rise and fall times are in the tens of nanoseconds, and must be treated as high speed logic devices. The bypass capacitor must be as close to the supply pin as possible and connected to a solid ground plane, and preferably directly between the ($V+$) and GND pins.

Minimize coupling between outputs and inputs to prevent output oscillations. Do not run output and input traces in parallel unless there is a (V+) or GND trace between output to reduce coupling. When series resistance is added to inputs, place resistor close to the device. A low value (<math><100\Omega</math>) resistor can also be added in series with the output to dampen any ringing or reflections on long, non-impedance controlled traces. For best edge shapes, controlled impedance traces with back-terminations can be used when routing long distances.

7.4.2 Layout Example

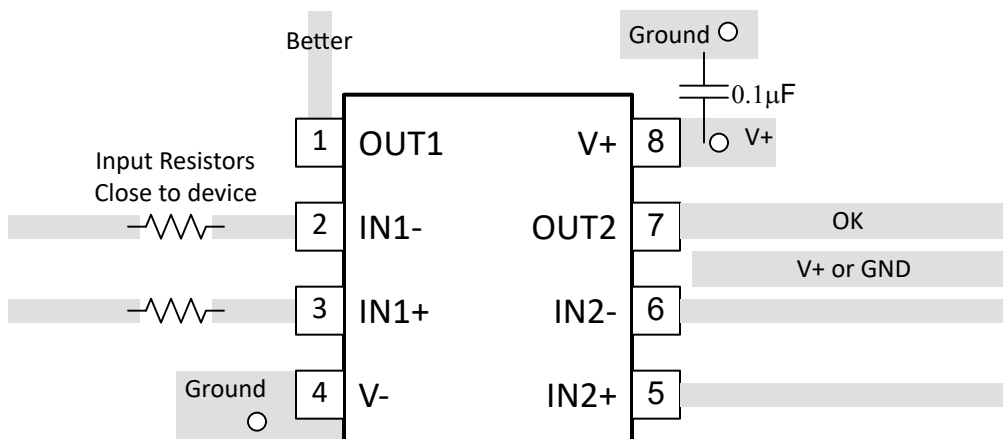


Figure 7-9. Dual Layout Example

8 Device and Documentation Support

8.1 Documentation Support

8.1.1 Related Documentation

[Analog Engineers Circuit Cookbook: Amplifiers \(See Comparators section\) - SLYY137](#)

[Precision Design, Comparator with Hysteresis Reference Design— TIDU020](#)

[Comparator with and without hysteresis circuit - SBOA219](#)

[Inverting comparator with hysteresis circuit - SNOA997](#)

[Non-Inverting Comparator With Hysteresis Circuit - SBOA313](#)

8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.3 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

8.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

8.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.6 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| Changes from Revision B (December 2024) to Revision C (June 2025) | Page |
|--------------------------------------------------------------------------|-------------|
| • Added separate propagation delay data for DUAL channel option..... | 1 |

| Changes from Revision A (September 2024) to Revision B (December 2024) | Page |
|-------------------------------------------------------------------------------|-------------|
| • Released the dual TLV3232 throughout document..... | 1 |

Changes from Revision * (August 2024) to Revision A (September 2024)

Page

- Production Data release for the SOT-23..... **1**
-

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

| Orderable part number | Status (1) | Material type (2) | Package Pins | Package qty Carrier | RoHS (3) | Lead finish/ Ball material (4) | MSL rating/ Peak reflow (5) | Op temp (°C) | Part marking (6) |
|-----------------------------|---------------|----------------------|------------------|-----------------------|-------------|--------------------------------------|-----------------------------------|-----------------|---------------------|
| TLV3231DBVR | Active | Production | SOT-23 (DBV) 5 | 3000 LARGE T&R | Yes | SN | Level-1-260C-UNLIM | -40 to 125 | 3HGH |
| TLV3231DBVR.A | Active | Production | null (null) | 3000 LARGE T&R | - | SN | Level-1-260C-UNLIM | See TLV3231DBVR | 3HGH |
| TLV3231DCKR | Active | Production | SC70 (DCK) 5 | 3000 LARGE T&R | Yes | SN | Level-1-260C-UNLIM | -40 to 125 | 1SQ |
| TLV3231DCKR.A | Active | Production | null (null) | 3000 LARGE T&R | - | SN | Level-1-260C-UNLIM | See TLV3231DCKR | 1SQ |
| TLV3232DGKR | Active | Production | VSSOP (DGK) 8 | 2500 LARGE T&R | Yes | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | 3MSS |
| TLV3232DGKR.A | Active | Production | null (null) | 2500 LARGE T&R | - | NIPDAU | Level-1-260C-UNLIM | See TLV3232DGKR | 3MSS |
| TLV3232DSGR | Active | Production | WSON (DSG) 8 | 3000 LARGE T&R | Yes | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | 3232 |

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF TLV3231, TLV3232 :

- Automotive : [TLV3231-Q1](#), [TLV3232-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| TLV3231DBVR | SOT-23 | DBV | 5 | 3000 | 180.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q3 |
| TLV3231DCKR | SC70 | DCK | 5 | 3000 | 180.0 | 8.4 | 2.3 | 2.5 | 1.2 | 4.0 | 8.0 | Q3 |
| TLV3232DGKR | VSSOP | DGK | 8 | 2500 | 330.0 | 12.4 | 5.3 | 3.4 | 1.4 | 8.0 | 12.0 | Q1 |
| TLV3232DSGR | WSO8 | DSG | 8 | 3000 | 180.0 | 8.4 | 2.3 | 2.3 | 1.15 | 4.0 | 8.0 | Q2 |

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|-------------|--------------|-----------------|------|------|-------------|------------|-------------|
| TLV3231DBVR | SOT-23 | DBV | 5 | 3000 | 210.0 | 185.0 | 35.0 |
| TLV3231DCKR | SC70 | DCK | 5 | 3000 | 210.0 | 185.0 | 35.0 |
| TLV3232DGKR | VSSOP | DGK | 8 | 2500 | 353.0 | 353.0 | 32.0 |
| TLV3232DSGR | WSON | DSG | 8 | 3000 | 210.0 | 185.0 | 35.0 |

DCK0005A



PACKAGE OUTLINE

SOT - 1.1 max height

SMALL OUTLINE TRANSISTOR



4214834/G 11/2024

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Reference JEDEC MO-203.
4. Support pin may differ or may not be present.
5. Lead width does not comply with JEDEC.
6. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25mm per side

EXAMPLE BOARD LAYOUT

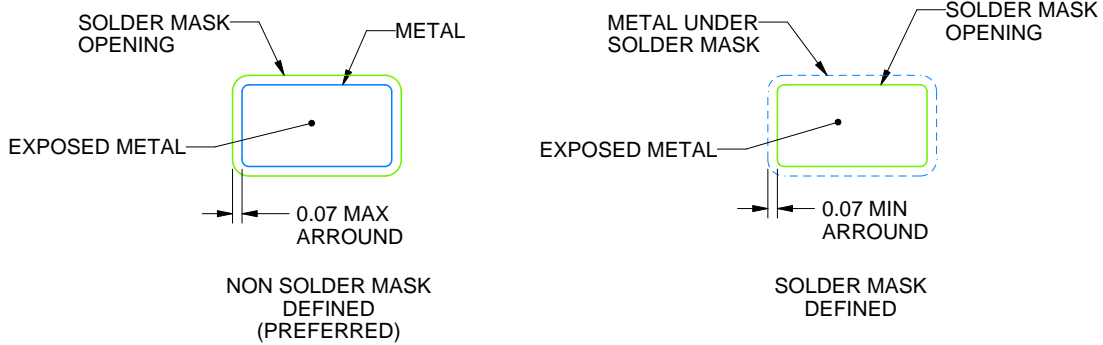
DCK0005A

SOT - 1.1 max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:18X



SOLDER MASK DETAILS

4214834/G 11/2024

NOTES: (continued)

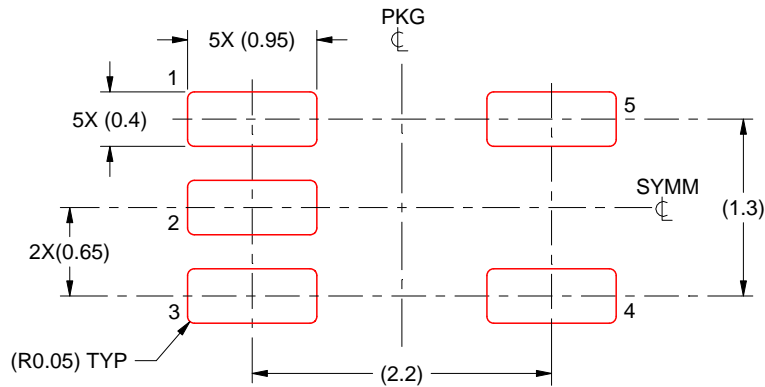
- 7. Publication IPC-7351 may have alternate designs.
- 8. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DCK0005A

SOT - 1.1 max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE
BASED ON 0.125 THICK STENCIL
SCALE: 18X

4214834/G 11/2024

NOTES: (continued)

9. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
10. Board assembly site may have different recommendations for stencil design.

GENERIC PACKAGE VIEW

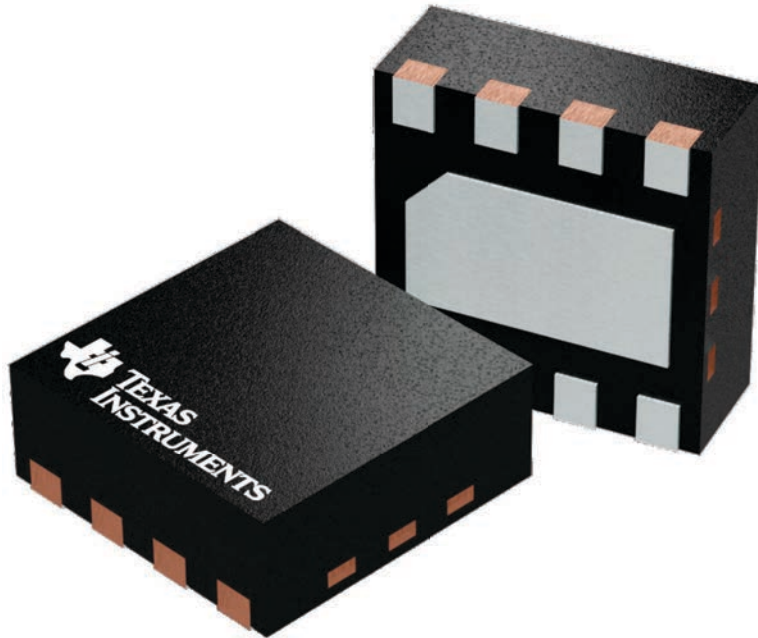
DSG 8

WSON - 0.8 mm max height

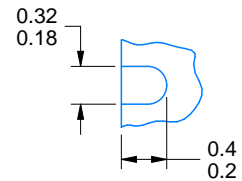
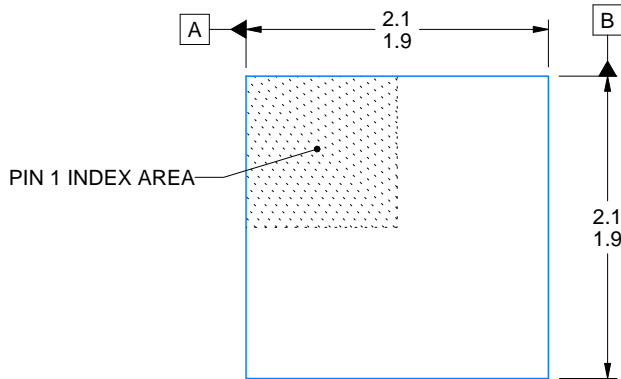
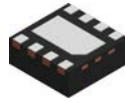
2 x 2, 0.5 mm pitch

PLASTIC SMALL OUTLINE - NO LEAD

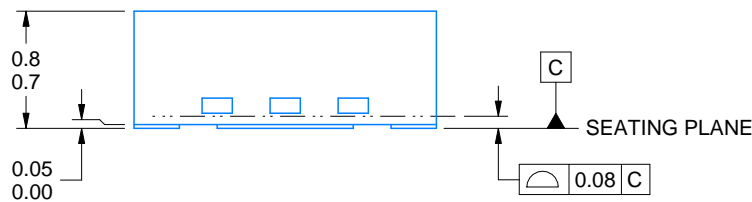
This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



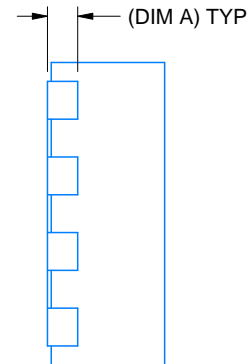
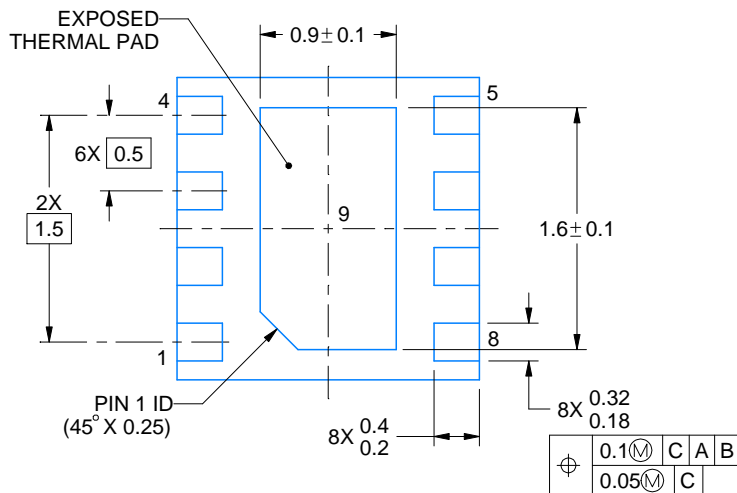
4224783/A



ALTERNATIVE TERMINAL SHAPE TYPICAL



| SIDE WALL METAL THICKNESS DIM A | |
|---------------------------------|----------|
| OPTION 1 | OPTION 2 |
| 0.1 | 0.2 |



4218900/E 08/2022

NOTES:

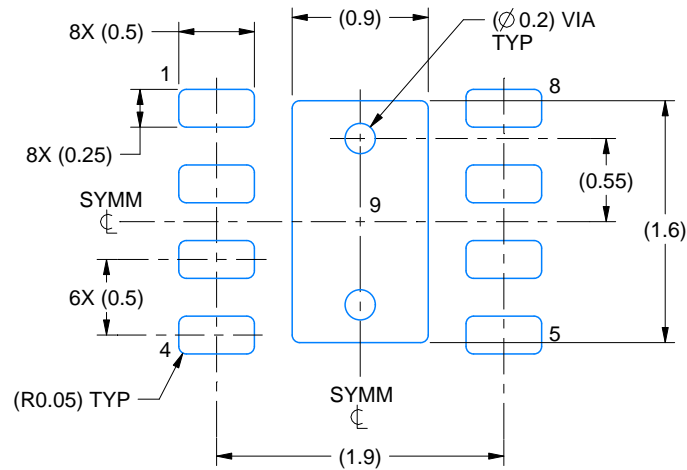
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

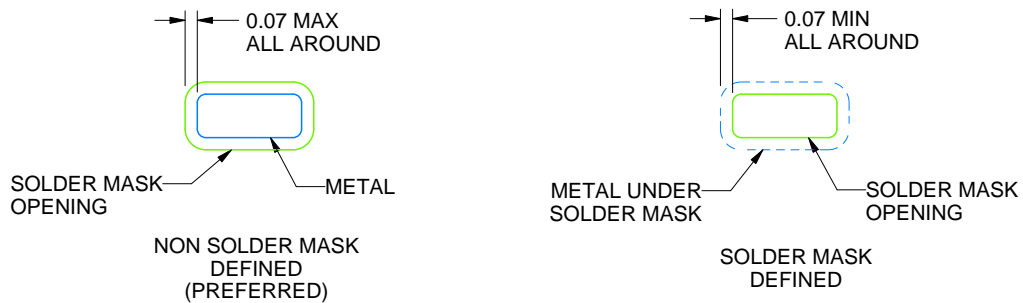
DSG0008A

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE
SCALE:20X



SOLDER MASK DETAILS

4218900/E 08/2022

NOTES: (continued)

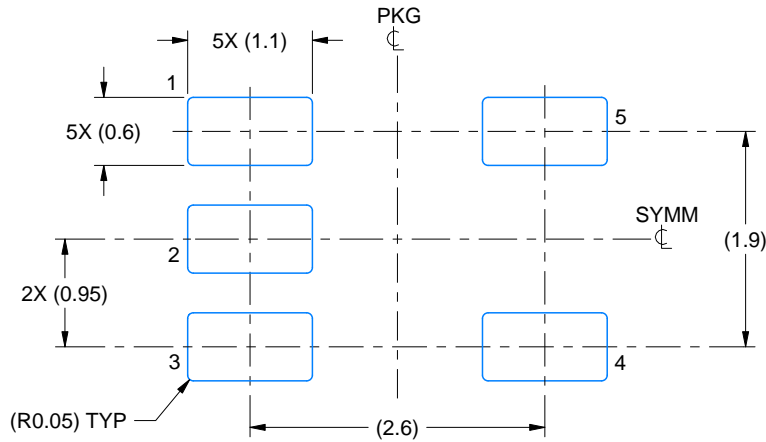
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE BOARD LAYOUT

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

4214839/K 08/2024

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

4214839/K 08/2024

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

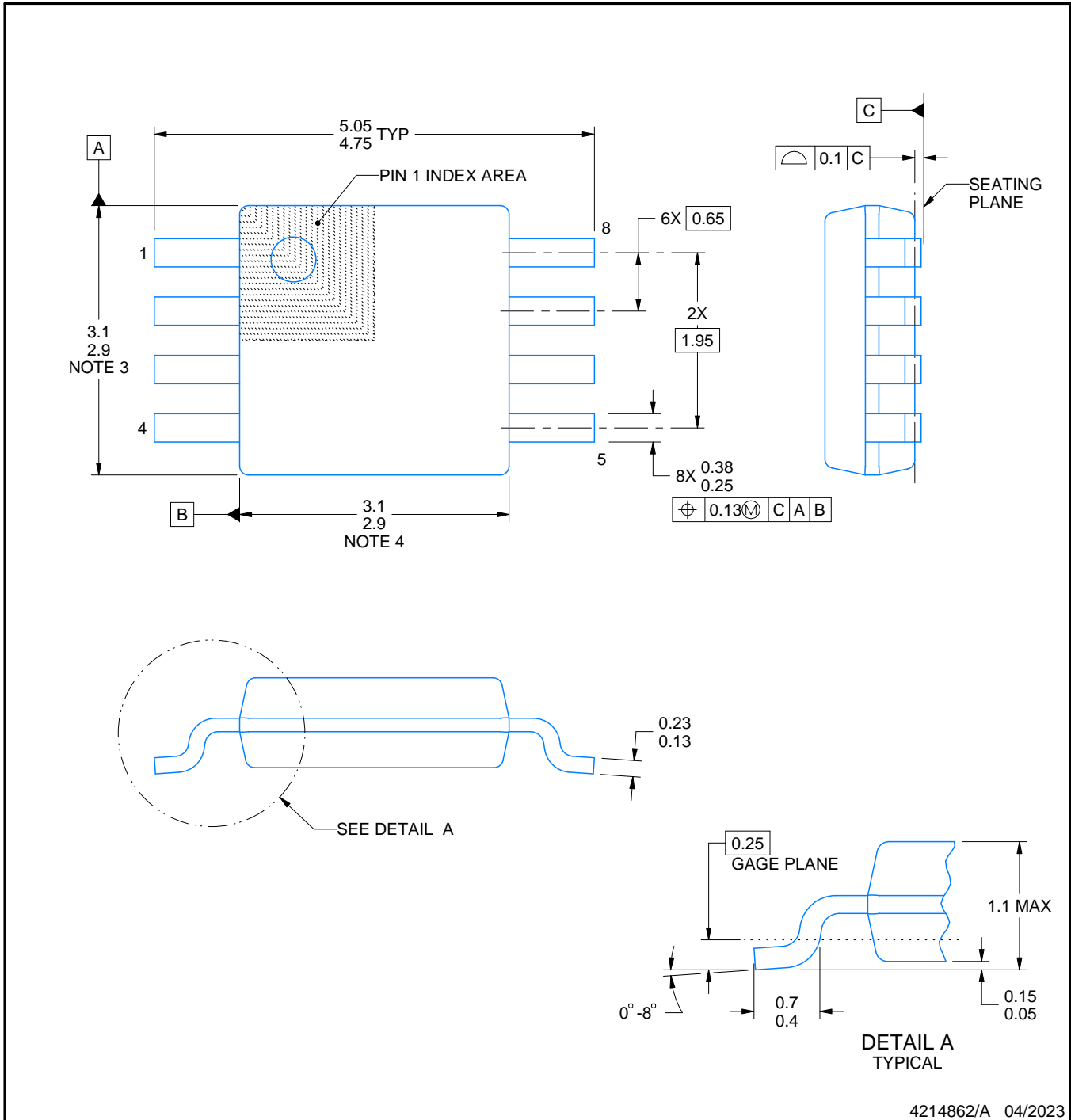
DGK0008A



PACKAGE OUTLINE

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



4214862/A 04/2023

NOTES:

PowerPAD is a trademark of Texas Instruments.

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187.

EXAMPLE BOARD LAYOUT

DGK0008A

™ VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 15X



SOLDER MASK DETAILS

4214862/A 04/2023

NOTES: (continued)

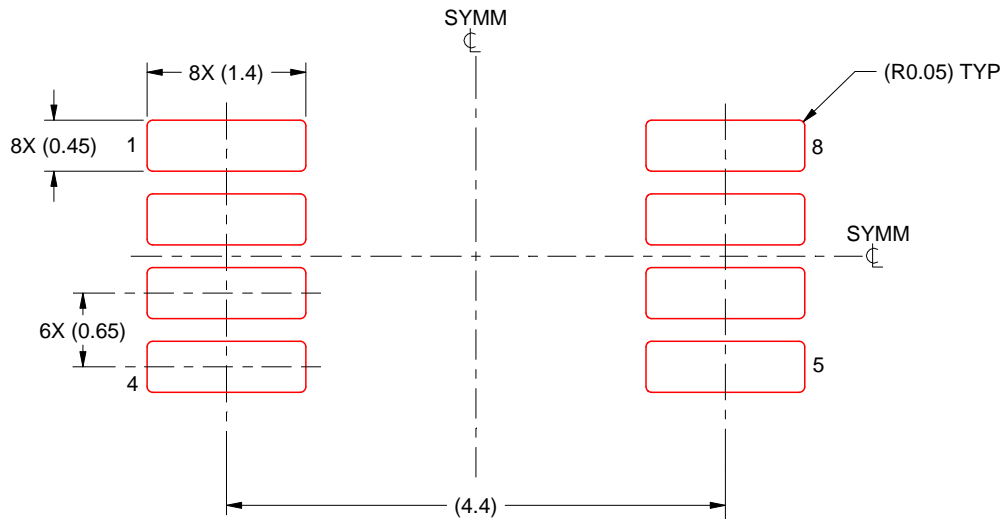
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
9. Size of metal pad may vary due to creepage requirement.

EXAMPLE STENCIL DESIGN

DGK0008A

TM VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
SCALE: 15X

4214862/A 04/2023

NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.

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